

WHAT IS CLAIMED IS:

1. A method of manufacturing a thin-film magnetic head, the method comprising the steps of:

forming a first magnetic pole layer;

5 removing both sides in a track width direction of the first magnetic pole layer so as to leave a predetermined residual area in the first magnetic pole layer;

10 forming an insulating layer about the residual area of the first magnetic pole layer;

forming a gap layer made of a nonmagnetic material on the residual area of the first magnetic pole layer and the insulating layer;

15 forming on the gap layer a second magnetic pole layer magnetically connected to the first magnetic pole; and

patterning the second magnetic pole layer by etching while using a mask.

20 2. A method of manufacturing a thin-film magnetic head according to claim 1, wherein the insulating layer is formed from  $\text{Al}_2\text{O}_3$ .

25 3. A method of manufacturing a thin-film magnetic head according to claim 1, wherein the residual area of the first magnetic pole layer has a width of about  $0.5\ \mu\text{m}$  to about  $2.0\ \mu\text{m}$  in the track width direction.

4. A method of manufacturing a thin-film magnetic head according to claim 1, wherein the first magnetic pole layer is constructed by laminating a plurality of magnetic layers;

5 wherein at least the topmost layer in the plurality of magnetic layers is formed with the residual area; and

wherein the insulating layer is formed on both sides in the track width direction of the residual area.